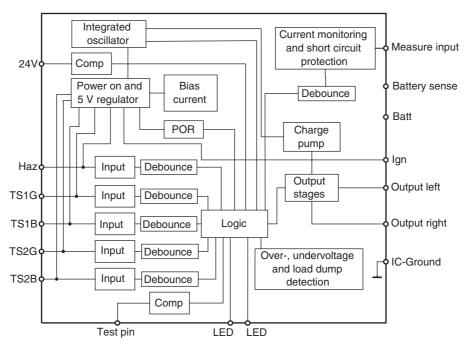


Figure 1-1. Block Diagram



2. Pin Configuration

Figure 2-1. Pinning SO16

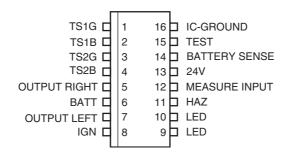


Table 2-1.Pin Description

Pin	Symbol	Direction	Function
1	TS1G	In	Input left turn switch to ground ⁽¹⁾
2	TS1B	In	Input left turn switch to battery ⁽¹⁾
3	TS2G	In	Input right turn switch to ground
4	TS2B	In	Input right turn switch to battery
5	OUTPUT RIGHT	Out	Relay driver right side
6	BATT	Supply	Power battery voltage Battery force
7	OUTPUT LEFT	Out	Relay driver left side
8	IGN	In	Ignition input
9	LED	ln	Open: regular frequency Switch to IC-ground: LED outage left side, external signal frequency doubling left side ⁽²⁾
10	LED	ln	Open: normal work Switch to IC-ground: LED outage right side, external signal frequency doubling right side ⁽²⁾
11	HAZ	In	Input switch to hazard warning
12	MEASURE INPUT	In	Voltage drop at the shunt resistor
13	24V	ln	Switch to 24V version: Open enables overvoltage shut down function, connecting to IC-ground disables overvoltage shut down function
14	BATTERY SENSE	In	Sense battery voltage for the internal comparator with high precision
15	TEST PIN		Either not connected or connected to IC-ground
16	IC-GROUND	Supply	IC-ground

Note:

- 1. Use either switches to ground pin 1 and 3 or switches to battery pin 2 and 4
- 2. These pins can be connected optional by using LED flashlights to indicate outage. If a LED pin is on low level, frequency doubling is active, independent of pin MEASURE INPUT.





3. Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Symbol	Value	Unit
Supply voltage, pin 6	V _{VS}	6 to 40	V
Ambient temperature range	T _{amb}	-40 to +105	°C
Junction temperature range	T _j	-40 to +150	°C
Storage temperature range	T _{stg}	-55 to +150	°C

4. Thermal Resistance

Parameters	Symbol	Value	Unit
Maximum thermal resistance SO16	R _{thJA}	110	K/W

5. Operating Range

Parameters	Symbol	Value	Unit
Supply voltage, pin 6	V _{VS}	6 to 24	V
Supply voltage, pin 6 (24V version, pin 13 to GND)	V _{VS}	18 to 33	٧

6. Noise and Surge Immunity

Parameters	Test Conditions	Value
Conducted interferences ⁽¹⁾	ISO 7637-1	Level 4
CCD (Human Dady Madel)	MIL-STD-883D Method 3015.7 ⁽²⁾	2 kV
ESD (Human Body Model)	MIL-STD-883D Method 3015.7 (pin 12 and pin 14)	1 kV
ESD FCDM (Field induced Charge Device Model)	ESD - S. 5.3	500V

Note:

- 1. At both outputs a relay of minimum 130 Ω should be added (for details see application circuits Figure 11-2 on page 8 to Figure 11-9 on page 12).
- 2. Exclusive pin 12 and pin 14.

ATA6140 i

7. Electrical Characteristics

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
1	Supply Voltage Range			<u>'</u>	"	'	"	1	
1.1	Supply voltage		6	V _{VS}	8		16	V	С
1.1	Supply voltage (24V version)		6	V _{VS}	18		33	V	С
2	Current Consumption								
2.1	Quiescent current (V _S)	V _{VS} < 16V switches open	6	I _{vs}			10	μΑ	А
2.1	Quiescent current (V _S , 24V version)	V _{VS} < 33V switches open	6	I _{vs}			20	μA	А
2.2	Supply current (V _S)	V _{VS} < 16V	6	I _{vs}			6	mA	Α
2.2	Supply current (V _S , 24V version)	V _{VS} < 33V	6	I _{vs}			8	mA	Α
3	Under and Overvoltage	e Detection		1	1	1	1	I	1
3.1	Undervoltage detection threshold		6	V _{VU}	6		8	V	А
3.2	Undervoltage detection delay time			t _{dUV}	2.5		10	ms	Α
3.3	Overvoltage detection threshold		6	V _{VO}	18		22	V	Α
3.3	Overvoltage detection threshold (24V version)	Disabled in 24V version (pin 13 to GND)	6	V _{VO}				V	А
4	Relay Outputs								
4.1	Current output right		5	I ₁₅			170	mA	Α
4.2	Current output left		7	I ₁₇			170	mA	Α
4.3	Saturation voltage right	170 mA at 23°C	5	V _{SATR}			1	V	Α
4.4	Saturation voltage left	170 mA at 23°C	7	V _{SATL}			1	V	Α
4.5	Leakage current right		5	I _{LEAKR}			3	μΑ	Α
4.5	Leakage current right (24V version)		5	I _{LEAKR}			6	μA	Α
4.6	Leakage current left		7	I _{LEAKL}			3	μΑ	Α
4.6	Leakage current left (24V version)		7	I _{LEAKL}			6	μA	Α
4.7	Start delay time right		5	T _{DR}	10		40	ms	Α
4.8	Start delay time left		7	T _{DL}	10		40	ms	Α
5	Control Signal Thresh	olds		1				11	
5.1	Frequency doubling	$V_S = 9V$	12	V_{THFD9}	42	45	48	mV	Α
5.2	Frequency doubling	V _S = 15V	12	V _{THFD15}	50	53	57	mV	Α
5.2	Frequency doubling (24V version)	V _S = 24V	12	V _{THFD24}		65		mV	Α
5.3	Short circuit detection	V _S = 13.5V	12	V _{THSC}	425	475	525	mV	В
5.3	Short circuit detection (24V version)	V _S = 24V	12	V _{THSC}		650		mV	В

^{*)} Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter





7. Electrical Characteristics (Continued)

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
5.4	Temperature coefficient	-40°C to +105°C	12	Стн		30		μV/K	С
5.5	Input current	V _S = 13.5 V	12	I _{TH}			2	μΑ	Α
5.5	Input current (24V version)	V _S = 24V	12	I _{TH}			4	μΑ	А
6	LED Inputs								
6.1	Threshold left	V _S = 13.5V	9	V_{LEDL}	1		4.5	V	Α
6.2	Threshold right	V _S = 13.5V	10	V_{LEDR}	1		4.5	V	Α
6.3	Pull-up resistor left		9	R _{LEDL}	10		75	kΩ	Α
6.4	Pull-up resistor right		10	R _{LEDR}	10		75	kΩ	Α
7	Timing								
7.1	Basic frequency	1/f = 706 ms		F _B	-10.5		+12	%	Α
7.2	Bright period					50		%	Α
7.3	Bright period in failure mode					40		%	А
7.4	Failure frequency			F _F			$2.2 \times F_B$		Α
7.5	Debounce time	Bulb outage detection	12		3.6	5	6.2	ms	

^{*)} Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

8. Short Circuit or Overload Detection Delay

Direction mode:

100 ms during the first bright phase, 50 ms during all following bright phases

Hazard mode: 100 ms during all bright phases

In case of overload the relay output switches off (not stored)

9. Bulb Outage Detection

The detection of bulb outage takes place during the bright phase. There is a delay time of typically 128 ms before ATA6140 measures the bulb current with a debounce period of 5 ms. After this time the inrush current dropped significantly.

Application hint:

It has to be considered that a slow relay contact may shorten the inrush current decay time and too high current would be measured and falsely an outage may not be detected. If operated with low supply voltage (e.g., 8V) the relay speed could be even slower.

10. Flasher Operating Mode

Ignition	Input Left Ground	Input Right Ground	Input Left Ignition	Input Right Ignition	Input Hazard	Left Lamps ⁽¹⁾	Right Lamps ⁽¹⁾	Frequency in Case of Lamp Failure ⁽¹⁾
Off	Open	Open	IC-ground	IC-ground	Open	х	х	х
Off	Ground	Open	IC-ground	IC-ground	Open	x	Х	х
Off	Open	Ground	IC-ground	IC-ground	Open	х	Х	х
Off	Open	Open	IC-ground	IC-ground	Ground	Flash	Flash	Normal
Off	Ground	Open	IC-ground	IC-ground	Ground	Flash	Flash	Normal
Off	Open	Ground	IC-ground	IC-ground	Ground	Flash	Flash	Normal
Off	Ground	Ground	IC-ground	IC-ground	Ground	Flash	Flash	Normal
Off	Ground	Ground	IC-ground	IC-ground	Open	х	х	x ⁽²⁾
On	Open	Open	IC-ground	IC-ground	Open	х	х	х
On	Ground	Open	IC-ground	IC-ground	Open	Flash	х	Double
On	Open	Ground	IC-ground	IC-ground	Open	х	Flash	Double
On	Open	Open	IC-ground	IC-ground	Ground	Flash	Flash	Normal
On	Ground	Open	IC-ground	IC-ground	Ground	Flash	Flash	Normal
On	Open	Ground	IC-ground	IC-ground	Ground	Flash	Flash	Normal
On	Ground	Ground	IC-ground	IC-ground	Ground	Flash	Flash	Normal
On	Ground	Ground	IC-ground	IC-ground	Open	Flash	Flash	Normal
Off	V_{BATT}	V _{BATT}	Open	Open	Open	х	Х	х
Off	V_{BATT}	V _{BATT}	Ignition	Open	Open	х	Х	x
Off	V_{BATT}	V _{BATT}	Open	Ignition	Open	х	Х	x
Off	V_{BATT}	V _{BATT}	Open	Open	Ground	Flash	Flash	Normal
Off	V_{BATT}	V _{BATT}	Ignition	Open	Ground	Flash	Flash	Normal
Off	V_{BATT}	V _{BATT}	Open	Ignition	Ground	Flash	Flash	Normal
Off	V_{BATT}	V _{BATT}	Ignition	Ignition	Ground	Flash	Flash	Normal
Off	V_{BATT}	V _{BATT}	Ignition	Ignition	Open	х	Х	x ⁽³⁾
On	V_{BATT}	V _{BATT}	Open	Open	Open	х	Х	х
On	V_{BATT}	V_{BATT}	Ignition	Open	Open	Flash	Х	Double
On	V_{BATT}	V _{BATT}	Open	Ignition	Open	х	Flash	Double
On	V_{BATT}	V _{BATT}	Open	Open	Ground	Flash	Flash	Normal
On	V_{BATT}	V _{BATT}	Ignition	Open	Ground	Flash	Flash	Normal
On	V_{BATT}	V _{BATT}	Open	Ignition	Ground	Flash	Flash	Normal
On	V_{BATT}	V _{BATT}	Ignition	Ignition	Ground	Flash	Flash	Normal
On	V _{BATT}	V _{BATT}	Ignition	Ignition	Open	Flash	Flash	Normal

Notes: 1. x = no flashing



^{2.} If ignition is OFF, the input level cannot be sensed (the IC is in the sleep mode). For hazard mode use the input hazard.

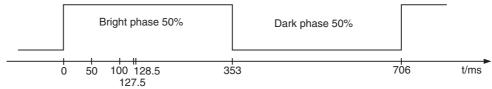
^{3.} For hazard mode use input hazard or switch to battery as shown in Figure 11-4 on page 9 and Figure 11-8 on page 11.



11. Diagrams

Figure 11-1. Timing Diagram

Basic Frequency



50 ms - 353 ms => short circuit detection

100 ms - 353 ms => short circuit detection during first bright phase (turn signal mode)

100 ms - 353 ms => short circuit detection during each bright phase (hazard signal mode)

127.5 ms - 128.5 ms => lamp outage detection

Doubled Frequency

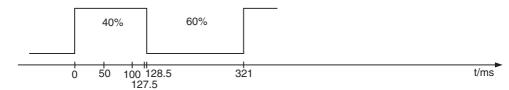
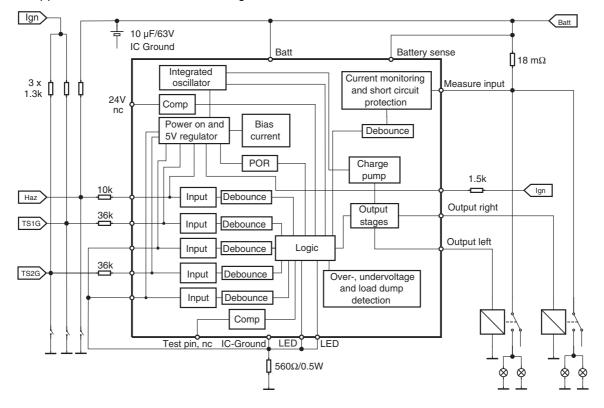


Figure 11-2. Application 1: 12V Version, Turn Signal Switches to GND, Hazard Switch to GND



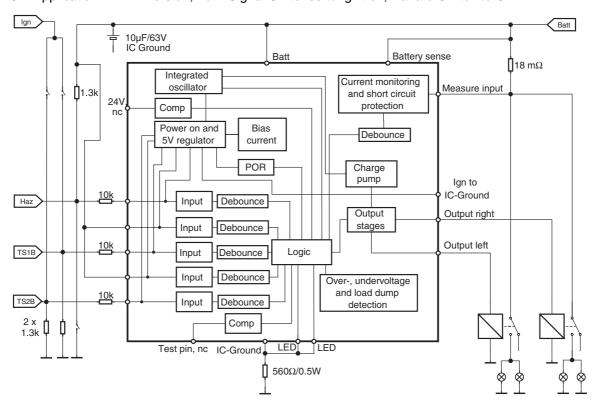


Figure 11-3. Application 2: 12V Version, Turn Signal Switches to Ignition, Hazard Switch to GND

Figure 11-4. Application 3: 12V Version, Turn Signal Switches to Ignition, Hazard Switch to Battery

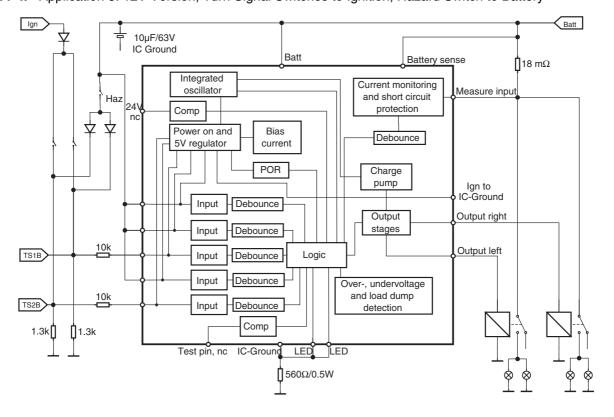






Figure 11-5. Application 4: 12V Version, Turn Signal Switches to Ignition, Hazard Switch to GND, additional LED Outage

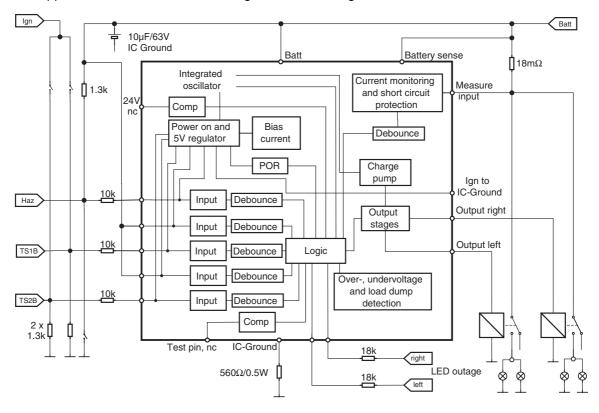
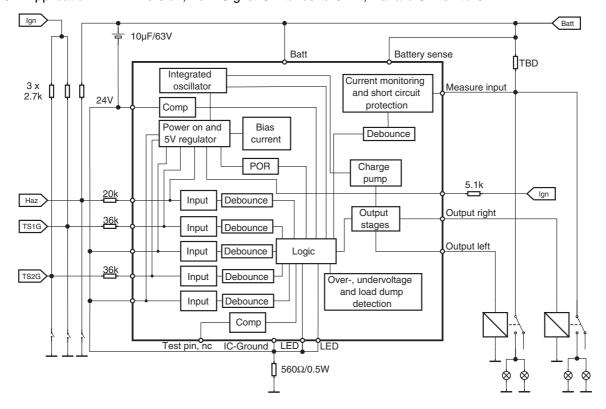


Figure 11-6. Application 1: 24V Version, Turn Signal Switches to GND, Hazard Switch to GND



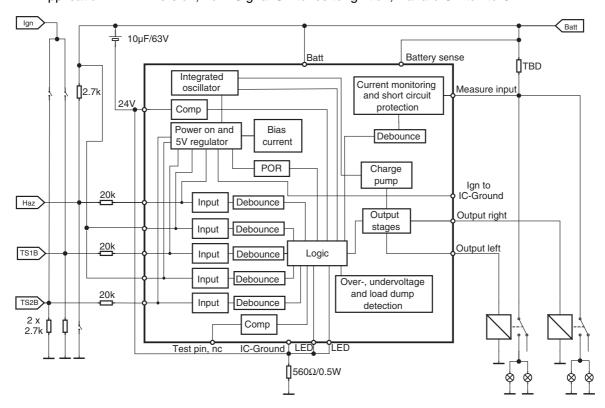


Figure 11-7. Application 2: 24V Version, Turn Signal Switches to Ignition, Hazard Switch to GND

Figure 11-8. Application 3: 24V Version, Turn Signal Switches to Ignition, Hazard Switch to Battery

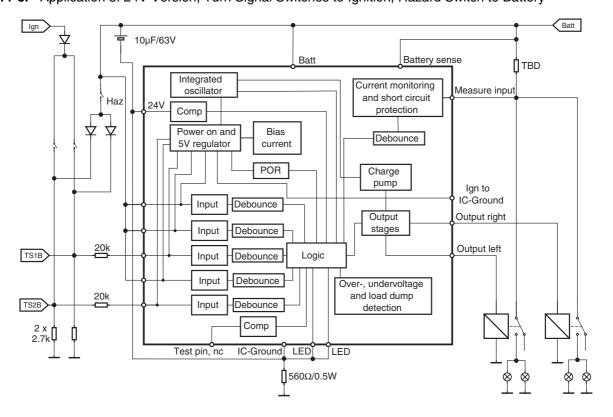
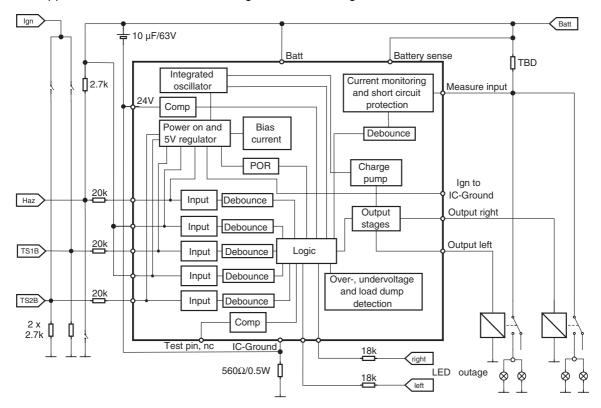






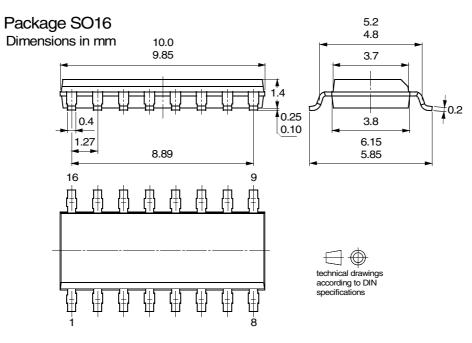
Figure 11-9. Application 4: 24V Version, Turn Signal Switches to Ignition, Hazard Switch to GND, additional LED Outage



12. Ordering Information

Extended Type Number	Package	Remarks
ATA6140-TBQY	SO16	Taped and reeled, Pb-free

13. Package Information



14. Revision History

Please note that the following page numbers referred to in this section refer to the specific revision mentioned, not to this document.

Revision No.	History
	Put datasheet in a new template
4560E-AUTO-09/05	Pb-free logo on page 1 added
	Ordering Information on page 13 changed





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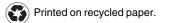
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